Advance Information

SWITCHMODE NPN Silicon Planar Power Transistor

The BUH51 has an application specific state—of—art die designed for use in 50 Watts Halogen electronic transformers.

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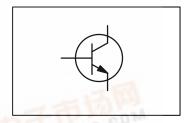
This power transistor is specifically designed to sustain the large inrush current during either the start—up conditions or under a short circuit across the load.

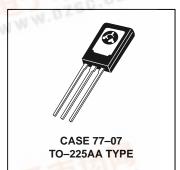
This High voltage/High speed product exhibits the following main features:

- Improved Efficiency Due to the Low Base Drive Requirements:
 - High and Flat DC Current Gain hFE
 - Fast Switching
- Robustness Thanks to the Technology Developed to Manufacture this Device
- Motorola "6 SIGMA" Philosophy Providing Tight and Reproducible Parametric Distributions

BUH51

POWER TRANSISTOR
3 AMPERES
800 VOLTS
50 WATTS





MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Sustaining Voltage	VCEO	500	Vdc
Collector–Base Breakdown Voltage	V _{CBO}	800	Vdc
Collector–Emitter Breakdown Voltage	VCES	800	Vdc
Emitter-Base Voltage	VEBO	10	Vdc
Collector Current — Continuous — Peak (1)	I _C	3 8	Adc
Base Current — Continuous — Peak (1)	I _B	2 4	Adc
*Total Device Dissipation @ T _C = 25°C *Derate above 25°C	PD	50 0.4	Watt W/°C
Operating and Storage Temperature	T _J , T _{stg}	-65 to 150	°C

THERMAL CHARACTERISTICS

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Thermal Resistance			°C/W
— Junction to Case	$R_{ heta JC}$	2.5	
— Junction to Ambient	$R_{\theta JA}$	100	
Maximum Lead Temperature for Soldering Purposes:	TL	260	°C
1/8" from case for 5 seconds			

⁽¹⁾ Pulse Test: Pulse Width = 5 ms, Duty Cycle ≤ 10%.

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This document contains information on a new product. Specifications and information herein are subject to change without notice.



ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

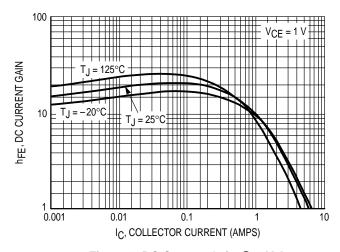
Characteristic			Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Collector–Emitter Sustainir (I _C = 100 mA, L = 25 mH			V _{CEO(sus)}	500	550		Vdc
Collector–Base Breakdown Voltage (ICBO = 1 mA)			V _{CBO}	800	950		Vdc
Emitter–Base Breakdown (IEBO = 1 mA)	/oltage		V _{EBO}	10	12.5		Vdc
Collector Cutoff Current (V _{CE} = Rated V _{CEO} , I _B	= 0)		ICEO			100	μAdc
Collector Cutoff Current (V _{CE} = Rated V _{CES} , V	EB = 0)	@ T _C = 25°C @ T _C = 125°C	ICES			100 1000	μAdc
Collector Base Current (V _{CB} = Rated V _{CBO} , V	EB = 0)	@ T _C = 25°C @ T _C = 125°C	ICBO			100 1000	μAdc
Emitter–Cutoff Current (V _{EB} = 9 Vdc, I _C = 0)			I _{EBO}			100	μAdc
ON CHARACTERISTICS							
Base–Emitter Saturation V (I _C = 1 Adc, I _B = 0.2 Add		@ T _C = 25°C @ T _C = 125°C	V _{BE(sat)}		0.92 0.8	1.1	Vdc
Collector–Emitter Saturation (I _C = 1 Adc, I _B = 0.2 Add	O .	@ T _C = 25°C @ T _C = 125°C	V _{CE(sat)}		0.3 0.32	0.5 0.6	Vdc
DC Current Gain (I _C = 1 A	dc, V _{CE} = 1 Vdc)	@ T _C = 25°C @ T _C = 125°C	hFE	8 6	10 8		_
$(I_C = 2 Ac)$	@ T _C = 25°C @ T _C = 125°C		5 4	7.5 6.2		_	
$(I_{C} = 0.8)$	@ T _C = 25°C @ T _C = 125°C		10 8	14 13		_	
(I _C = 10 r	@ T _C = 25°C @ T _C = 125°C		14 18	20 25		_	
DYNAMIC SATURATION V	DLTAGE	•					
Dynamic Saturation	I _C = 1 Adc, I _{B1} = 0.2 Adc V _{CC} = 300 V	@ T _C = 25°C	VCE(dsat)		1.7		V
Voltage:		@ T _C = 125°C]		6		V
Determined 3 μs after rising I _{B1} reaches 90% of final I _{B1}	I _C = 2 Adc, I _{B1} = 0.4 Adc V _{CC} = 300 V	@ T _C = 25°C			5.1		V
		@ T _C = 125°C			15		V
DYNAMIC CHARACTERIST	rics				_		
Current Gain Bandwidth (I _C = 1 Adc, V _{CE} = 10 Vdc, f = 1 MHz)			fT		23		MHz
Output Capacitance $(V_{CB} = 10 \text{ Vdc}, I_E = 0, f = 1 \text{ MHz})$			C _{ob}		34	100	pF
Input Capacitance (VEB = 8 Vdc, f = 1 MHz)			C _{ib}		200	500	pF

M. 18: 18 T. 11 B. 18.

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

	Symbol	Min	Тур	Max	Unit		
SWITCHING CHARACTER	RISTICS: Resistive Load (D.C.:	≤ 10%, Pulse Width	= 40 μs)		•		
Turn-on Time	I _C = 1 Adc, I _{B1} = 0.2 Adc I _{B2} = 0.2 Adc V _{CC} = 300 Vdc	@ T _C = 25°C @ T _C = 125°C	t _{on}		110 125	150	ns
Turn-off Time		@ T _C = 25°C @ T _C = 125°C	^t off		3.5 4.1	4	μs
Turn-on Time	I _C = 2 Adc, I _{B1} = 0.4 Adc	@ T _C = 25°C @ T _C = 125°C	^t on		700 1250	1000	ns
Turn-off Time	I _{B2} = 0.4 Adc V _{CC} = 300 Vdc	@ T _C = 25°C @ T _C = 125°C	^t off		1.75 2.1	2	μs
SWITCHING CHARACTER	RISTICS: Inductive Load (V _{clan}	np = 300 V, V _{CC} =	15 V, L = 200 μ	.H)			
Fall Time	I _C = 1 Adc I _{B1} = 0.2 Adc I _{B2} = 0.2 Adc	@ T _C = 25°C @ T _C = 125°C	^t fi		200 320	300	ns
Storage Time		@ T _C = 25°C @ T _C = 125°C	t _{Si}		3.4 4	3.75	μs
Crossover Time		@ T _C = 25°C @ T _C = 125°C	t _C		350 640	500	ns
Fall Time		@ T _C = 25°C @ T _C = 125°C	^t fi		140 300	200	ns
Storage Time	I _C = 2 Adc I _{B1} = 0.4 Adc I _{B2} = 0.4 Adc	@ T _C = 25°C @ T _C = 125°C	t _{si}		2.3 2.8	2.75	μs
Crossover Time		@ T _C = 25°C @ T _C = 125°C	t _C		400 725	600	ns

TYPICAL STATIC CHARACTERISTICS





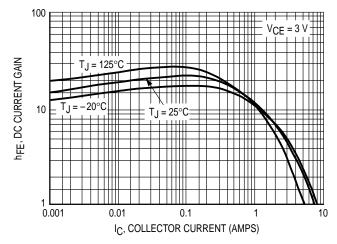


Figure 2. DC Current Gain @ 3 Volt

TYPICAL STATIC CHARACTERISTICS

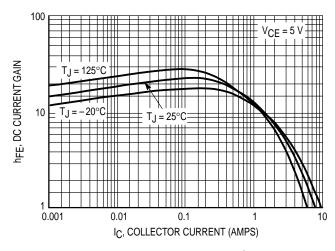


Figure 3. DC Current Gain @ 5 Volt

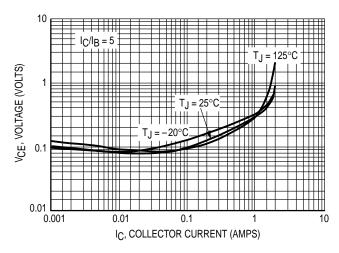


Figure 4. Collector–Emitter Saturation Voltage

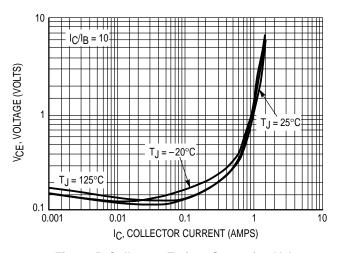


Figure 5. Collector-Emitter Saturation Voltage

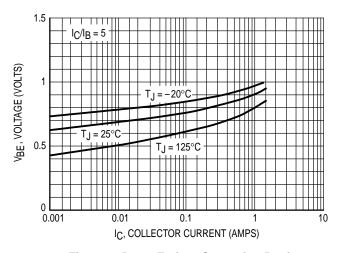


Figure 6. Base-Emitter Saturation Region

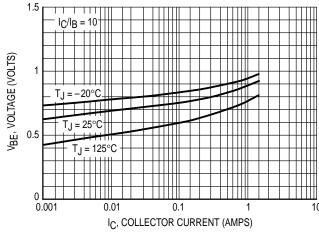


Figure 7. Base-Emitter Saturation Region

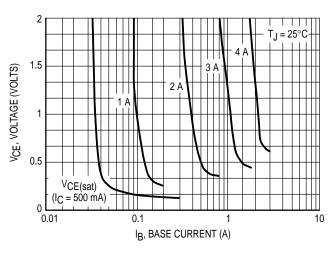
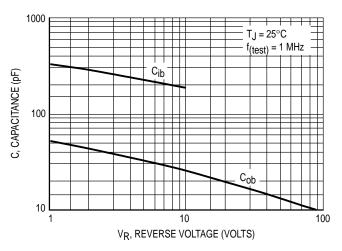


Figure 8. Collector Saturation Region

TYPICAL STATIC CHARACTERISTICS

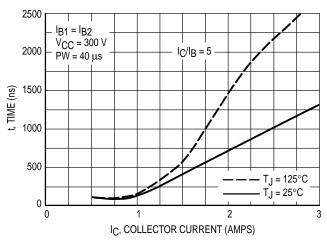


1000 900 800 **BVCER (VOLTS)** 700 BVCER @ 10 mA 600 BVCER(sus) @ 200 mA, 25 mH 500 400 10 100 1000 10000 100000 $\mathsf{R}_\mathsf{BE}\left(\Omega\right)$

Figure 9. Capacitance

Figure 10. Resistive Breakdown

TYPICAL SWITCHING CHARACTERISTICS



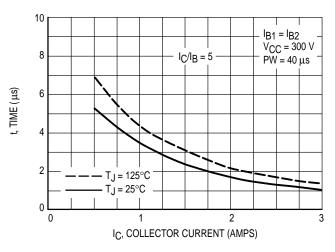
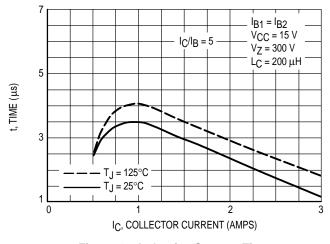


Figure 11. Resistive Switching, ton

Figure 12. Resistive Switch Time, toff



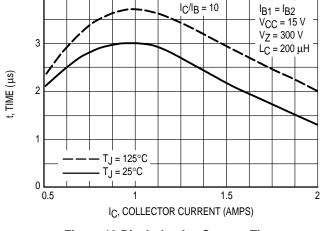


Figure 13. Inductive Storage Time, tsi

Figure 13 Bis. Inductive Storage Time, tsi

TYPICAL SWITCHING CHARACTERISTICS

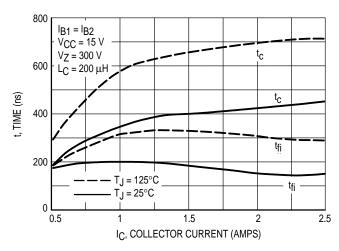


Figure 14. Inductive Storage Time, t_C & t_{fi} @ I_C/I_B = 5

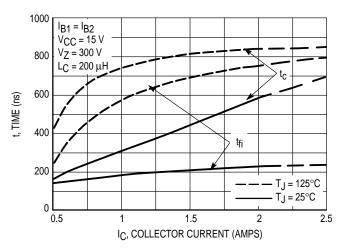


Figure 15. Inductive Storage Time, t_C & t_{fi} @ I_C/I_B = 10

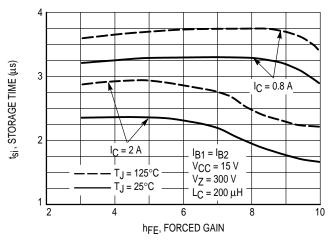


Figure 16. Inductive Storage Time

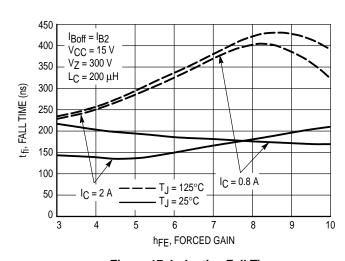


Figure 17. Inductive Fall Time

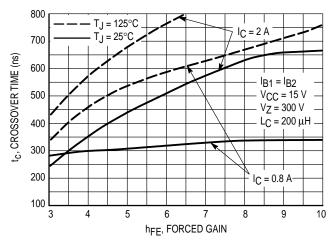
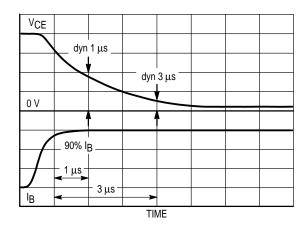


Figure 18. Inductive Crossover Time

TYPICAL SWITCHING CHARACTERISTICS

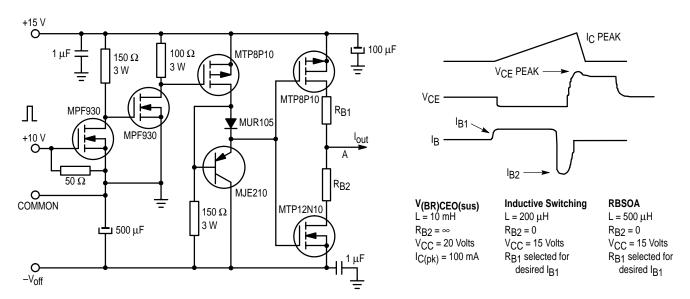


10 90% IC 9 8 t_{Si} 7 6 10% I_C 10% V_{clamp} V_{clamp} 5 90% I_{B1} 3 2 0 3 5 6 0 2 4 8 TIME

Figure 19. Dynamic Saturation Voltage Measurements

Figure 20. Inductive Switching Measurements

Table 1. Inductive Load Switching Drive Circuit



TYPICAL THERMAL RESPONSE

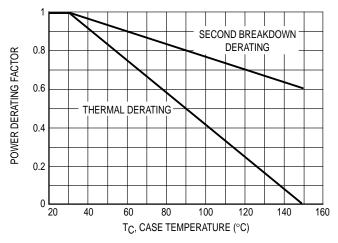
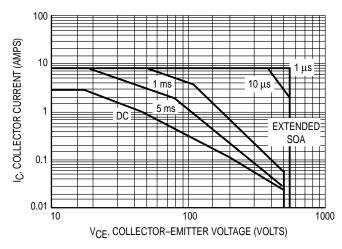


Figure 21. Forward Bias Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C-V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 22 is based on $T_C = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C > 25^{\circ}C$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 22 may be found at any case temperature by using the appropriate curve on Figure 21.

 $T_{J(pk)}$ may be calculated from the data in Figure 24. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn–off with the base to emitter junction reverse biased. The safe level is specified as a reverse biased safe operating area (Figure 23). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.



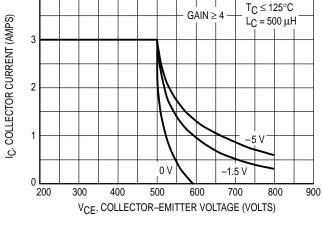


Figure 22. Forward Bias Safe Operating Area

Figure 23. Reverse Bias Safe Operating Area

TYPICAL THERMAL RESPONSE

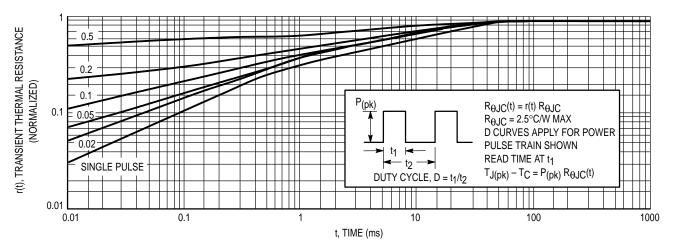
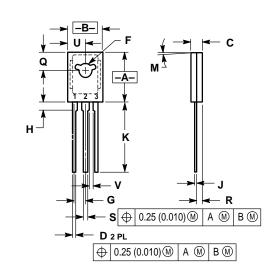


Figure 24. Typical Thermal Response (Z_θJC(t)) for BUH51

Maria Diagram

PACKAGE DIMENSIONS



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

		INC	HES	MILLIMETERS		
DIN	Λ	MIN	MAX	MIN	MAX	
Α		0.425	0.435	10.80	11.04	
В		0.295	0.305	7.50	7.74	
С		0.095	0.105	2.42	2.66	
D		0.020	0.026	0.51	0.66	
F		0.115	0.130	2.93	3.30	
G		0.094	BSC	2.39 BSC		
Н		0.050	0.095	1.27	2.41	
J		0.015	0.025	0.39	0.63	
K		0.575	0.655	14.61	16.63	
M		5° TYP		5° TYP		
Q		0.148	0.158	3.76	4.01	
R		0.045	0.055	1.15	1.39	
S		0.025	0.035	0.64	0.88	
U		0.145	0.155	3.69	3.93	
٧		0.040		1.02		

STYLE 1:
PIN 1. EMITTER
2. COLLECTOR
3. BASE

CASE 77-08 TO-225AA TYPE **ISSUE V**

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